





# **Phase Control Thyristor**

DS5949-3 January 2014 (LN31253)

## **FEATURES**

- **Double Side Cooling**
- High Surge Capability

## **APPLICATIONS**

- **High Power Drives** •
- **High Voltage Power Supplies**
- **Static Switches**

## **VOLTAGE RATINGS**

Part and Ordering Number	Repetitive Peak Voltages V <sub>DRM</sub> and V <sub>RRM</sub> V	Conditions
DCR1650C65* DCR1650C60 DCR1650C55 DCR1650C50	6500 6000 5500 5000	$\begin{array}{l} T_{vj} = -40^{\circ}C \text{ to } 125^{\circ}C, \\ I_{DRM} = I_{RRM} = 300\text{mA}, \\ V_{DRM}, V_{RRM} t_p = 10\text{ms}, \\ V_{DSM} \& V_{RSM} = \\ V_{DRM} \& V_{RRM} + 100\text{V} \\ \text{respectively} \end{array}$

Lower voltage grades available. \* 6200V @  $-40^{\circ}$  C, 6500V @  $0^{\circ}$  C

## **ORDERING INFORMATION**

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

## DCR1650C65

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

## **KEY PARAMETERS**

V <sub>DRM</sub>	6500V
I <sub>T(AV)</sub>	1650A
I <sub>TSM</sub>	22000A
dV/dt*	1500V/µs
dl/dt	300A/µs

## \* Higher dV/dt selections available

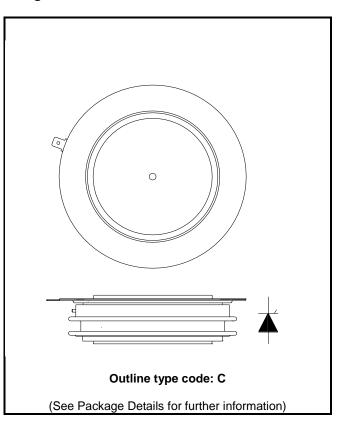


Fig. 1 Package outline



## **CURRENT RATINGS**

 $T_{case} = 60^{\circ}C$  unless stated otherwise

Symbol	Parameter	Test Conditions		Units
Double Sid	de Cooled			
I <sub>T(AV)</sub>	Mean on-state current	Half wave resistive load	1650	А
I <sub>T(RMS)</sub>	RMS value	-	2590	А
Ι <sub>Τ</sub>	Continuous (direct) on-state current	-	2575	А

# SURGE RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
I <sub>TSM</sub>	Surge (non-repetitive) on-state current	10ms half sine, $T_{case} = 125^{\circ}C$	22.0	kA
l <sup>2</sup> t	I <sup>2</sup> t for fusing	$V_R = 0$	2.42	MA <sup>2</sup> s

## THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions		Min.	Max.	Units
R <sub>th(j-c)</sub>	Thermal resistance – junction to case	Double side cooled	DC	-	0.0101	°C/W
		Single side cooled	Anode DC	-	0.0176	°C/W
			Cathode DC	-	0.0239	°C/W
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink	Clamping force 37kN	Double side	-	0.0025	°C/W
		(with mounting compound)	Single side	-	0.005	°C/W
$T_{vj}$	Virtual junction temperature	Blocking V <sub>DRM</sub> / <sub>VRRM</sub>		-	125	°C
T <sub>stg</sub>	Storage temperature range			-55	125	°C
Fm	Clamping force			33	41	kN



# **DYNAMIC CHARACTERISTICS**

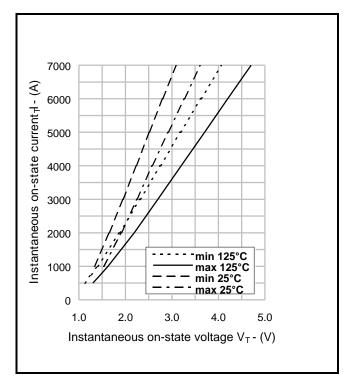
Symbol	Parameter	Test Conditions		Min.	Max.	Units
I <sub>RRM</sub> /I <sub>DRM</sub>	Peak reverse and off-state current	At V <sub>RRM</sub> /V <sub>DRM</sub> , T <sub>case</sub> = 125°C			300	mA
dV/dt	Max. linear rate of rise of off-state voltage	To 67% $V_{DRM}$ , $T_j = 125^{\circ}C$ , gate open		-	1500	V/µs
dl/dt	Rate of rise of on-state current	From 67% $V_{\text{DRM}}$ to 2x $I_{\text{T}(\text{AV})}$	Repetitive 50Hz	-	150	A/µs
		Gate source 30V, $10\Omega$ ,	Non-repetitive	-	300	A/µs
		$t_r < 0.5 \mu s, T_j = 125^{\circ}C$				
V <sub>T(TO)</sub>	Threshold voltage – Low level 100A to 1500A at T <sub>case</sub> = 125°C		-	1.0	V	
	Threshold voltage – High level	1500A to 7200A at $T_{case} = 125^{\circ}C$		-	1.2	V
۲ <sub>T</sub>	On-state slope resistance – Low level	100A to 1500A at T <sub>case</sub> = 125°C		-	0.615	mΩ
	On-state slope resistance – High level	1500A to 7200A at $T_{case} = 12$	25°C	-	0.5	mΩ
t <sub>gd</sub>	Delay time	$V_D = 67\% V_{DRM}$ , gate source	30V, 10Ω	-	3	μs
		$t_r = 0.5 \mu s, T_j = 25^{\circ}C$				
tq	Turn-off time	$T_j = 125^{\circ}C, V_R = 200V, dI/dt$	= 1A/µs,	-	1200	μs
		$dV_{DR}/dt = 20V/\mu s$ linear				
$Q_S$	Stored charge	$I_T = 2000A, T_j = 125^{\circ}C, dI/dt - 1A/\mu s,$		2000	4500	μC
١L	Latching current	$T_j = 25^{\circ}C, V_D = 5V$		-	3	А
I <sub>H</sub>	Holding current	$T_j = 25^{\circ}C, R_{G-K} = \infty, I_{TM} = 500$	0A, I <sub>T</sub> = 5A	-	300	mA



# GATE TRIGGER CHARACTERISTICS AND RATINGS

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>GT</sub>	Gate trigger voltage	$V_{DRM} = 5V, T_{case} = 25^{\circ}C$	1.5	V
$V_{GD}$	Gate non-trigger voltage	At 50% V <sub>DRM</sub> , T <sub>case</sub> = 125°C	0.4	V
I <sub>GT</sub>	Gate trigger current	$V_{DRM} = 5V, T_{case} = 25^{\circ}C$	350	mA
I <sub>GD</sub>	Gate non-trigger current	At 50% V <sub>DRM</sub> , T <sub>case</sub> = 125°C	15	mA

## **CURVES**



## Fig.2 Maximum & minimum on-state characteristics

## $V_{\text{TM}}$ EQUATION

Where A = 0.666848B = 0.033446 $V_{TM} = A + BIn (I_T) + C.I_T + D.\sqrt{I_T}$ C = 0.000418D = 0.009666these values are valid for  $T_j$  = 125°C for  $I_T$  100A to 7200A

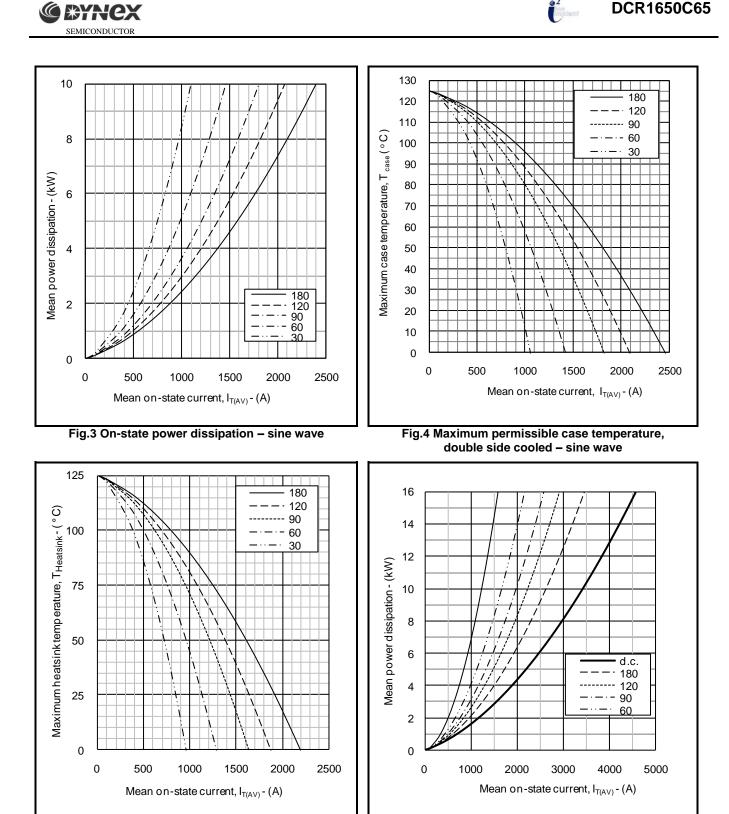
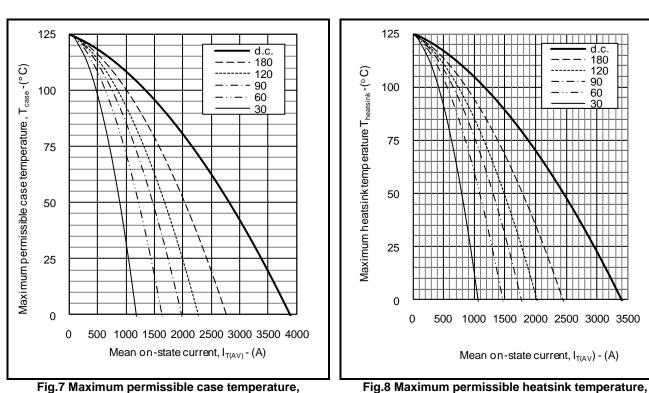
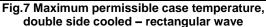


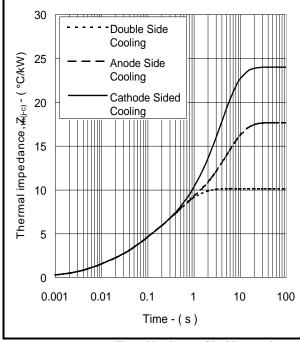
Fig.5 Maximum permissible heatsink temperature, double side cooled – sine wave

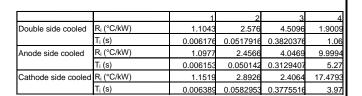






жYА SEMICONDUCTOR





double side cooled - rectangular wave

$$Z_{\text{th}} = \sum \left[ \mathsf{R}_{\mathsf{i}} \mathsf{x} ( \mathsf{1-exp.}(t/t_{\mathsf{i}})) \right]$$

 $\Delta R_{th(j\text{-}c)} \text{ Conduction}$ 

Tables show the increments of thermal resistance  $\mathsf{R}_{\mathsf{th}(j\text{-}c)}$  when the device operates at conduction angles other than d.c.

Double side cooling				Anode Side	Cooling	
	$\Delta Z_{th}$	(z)			$\Delta Z_t$	<sub>h</sub> (z)
θ°	sine.	rect.	1	θ°	sine.	rect.
180	1.95	1.26		180	1.95	1.26
120	2.32	1.89	I	120	2.32	1.89
90	2.74	2.27		90	2.74	2.27
60	3.14	2.70	I	60	3.14	2.70
30	3.46	3.19		30	3.46	3.19
15	3.61	3.47		15	3.62	3.47

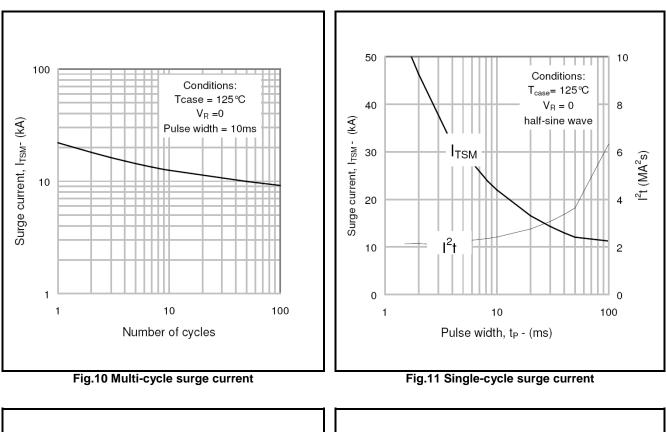
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1.26     180     1.95       1.89     120     2.31	1.26
1.89 120 2.31	
	1 0 0
2 27 00 2 72	1.00
2.21 30 2.12	2.26
2.70 60 3.12	2.68
3.19 30 3.43	3.17
3.47 15 3.58	3.44

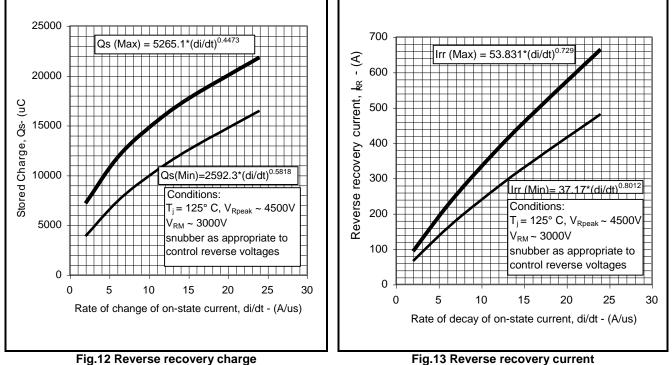
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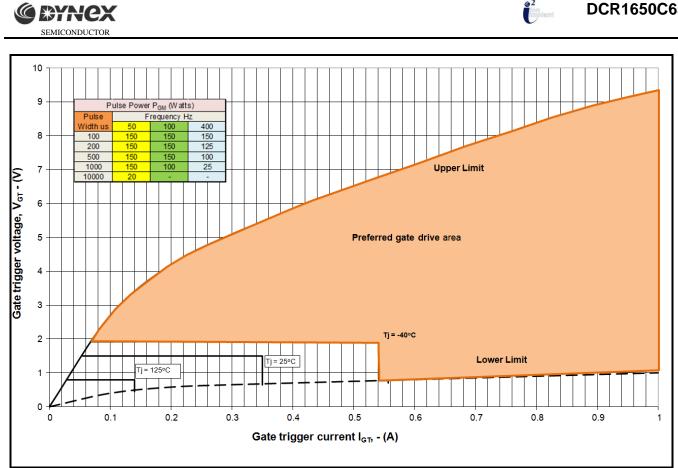












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DCR1650C65

**Fig14 Gate Characteristics** 

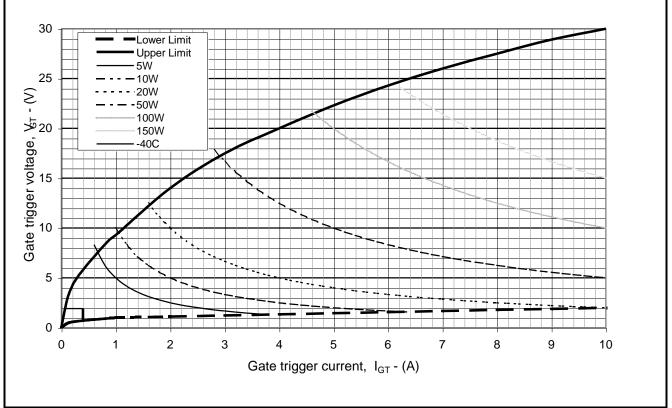


Fig. 15 Gate characteristics



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## PACKAGE DETAILS

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

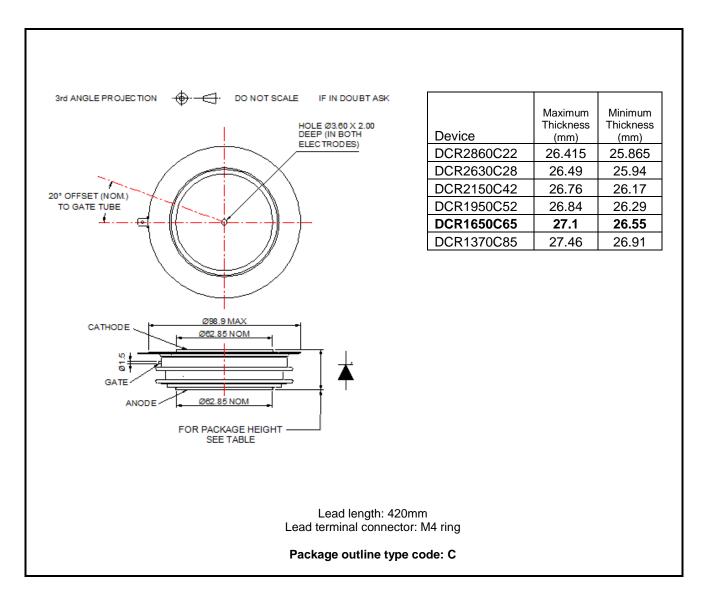


Fig.16 Package outline





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